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Measured Radio Frequency Emissions
From

Lear Corporation Transmitter
FCC ID: KOBKTF11A
IC: 3521A-KTF11A

Test Report No. 417124-601
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A handwritten signature in black ink, appearing to read "Valdis V. Liepa".

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Summary

Tests for compliance with FCC Regulations, CFR 47, Part 15 and with Industry Canada RSS-210/Gen, were performed on a Lear, FCC ID: KOBKTF11A, IC: 3521A-KTF11A. This device under test (DUT) is subject to the rules and regulations as a Transmitter.

In testing completed on February 21, 2011, the DUT tested met the allowed specifications for radiated emissions by 7.3 dB. Conducted emissions are not subject to regulation as the DUT is powered by a 3 VDC battery.

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1. Introduction

This Lear Transmitter was tested for compliance with FCC Regulations, Part 15, adopted under Docket 87-389, April 18, 1989 as subsequently amended, and with Industry Canada RSS-210/Gen, Issue 7, June 2007. Tests were performed at the University of Michigan Radiation Laboratory Willow Run Test Range following the procedures described in ANSI C63.4-2003 "Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz". The Site description and attenuation characteristics of the Open Site facility are on file with FCC Laboratory, Columbia, Maryland (FCC Reg. No: 91050) and with Industry Canada, Ottawa, ON (File Ref. No: IC 2057A-1).

2. Equipment Used

The test equipment commonly used in our facility is listed in Table 2.1. Except where indicated as a pre-test, monitoring, or support device; all equipment listed below is a part of the University of Michigan Radiation Laboratory (UMRL) quality system. This quality system has been established to ensure all equipment has a clearly identifiable classification, calibration expiry date, and that all calibrations are traceable to national standards.

Table 2.1 Test Equipment.

Test Instrument	Used	Manufacturer/Model	Q Number
Spectrum Analyzer (9kHz-26GHz)	<input checked="" type="checkbox"/>	Hewlett-Packard 8593E, SN: 3412A01131	HP8593E1
Spectrum Analyzer (9kHz-6.5GHz)	<input checked="" type="checkbox"/>	Hewlett-Packard 8595E, SN: 3543A01546	JDB8595E
Power Meter	<input type="checkbox"/>	Hewlett-Packard, 432A	HP432A1
Harmonic Mixer (26-40 GHz)	<input type="checkbox"/>	Hewlett-Packard 11970A, SN: 3003A08327	HP11970A1
Harmonic Mixer (40-60 GHz)	<input type="checkbox"/>	Hewlett-Packard 11970U, SN: 2332A00500	HP11970U1
Harmonic Mixer (75-110 GHz)	<input type="checkbox"/>	Hewlett-Packard 11970W, SN: 2521A00179	HP11970W1
Harmonic Mixer (140-220 GHz)	<input type="checkbox"/>	Pacific Millimeter Prod., GMA, SN: 26	PMPGMA1
S-Band Std. Gain Horn	<input type="checkbox"/>	S/A, Model SGH-2.6	SBAND1
C-Band Std. Gain Horn	<input type="checkbox"/>	University of Michigan, NRL design	CBAND1
XN-Band Std. Gain Horn	<input type="checkbox"/>	University of Michigan, NRL design	XNBAND1
X-Band Std. Gain Horn	<input type="checkbox"/>	S/A, Model 12-8.2	XBAND1
X-band horn (8.2- 12.4 GHz)	<input type="checkbox"/>	Narda 640	XBAND2
X-band horn (8.2- 12.4 GHz)	<input type="checkbox"/>	Scientific Atlanta , 12-8.2, SN: 730	XBAND3
K-band horn (18-26.5 GHz)	<input type="checkbox"/>	FXR, Inc., K638KF	KBAND1
Ka-band horn (26.5-40 GHz)	<input type="checkbox"/>	FXR, Inc., U638A	KABAND1
U-band horn (40-60 GHz)	<input type="checkbox"/>	Custom Microwave, HO19	UBAND1
W-band horn(75-110 GHz)	<input type="checkbox"/>	Custom Microwave, HO10	WBAND1
G-band horn (140-220 GHz)	<input type="checkbox"/>	Custom Microwave, HO5R	GBAND1
Bicone Antenna (30-250 MHz)	<input checked="" type="checkbox"/>	University of Michigan, RLBC-1	LBBIC1
Bicone Antenna (200-1000 MHz)	<input checked="" type="checkbox"/>	University of Michigan, RLBC-2	HBBIC1
Dipole Antenna Set (30-1000 MHz)	<input checked="" type="checkbox"/>	University of Michigan, RLDP-1,-2,-3	UMDIP1
Dipole Antenna Set (30-1000 MHz)	<input type="checkbox"/>	EMCO 3121C, SN: 992 (Ref. Antennas)	EMDIP1
Active Rod Antenna (30 Hz-50 MHz)	<input type="checkbox"/>	EMCO 3301B, SN: 3223	EMROD1
Active Loop Antenna (30 Hz-50 MHz)	<input type="checkbox"/>	EMCO 6502, SN:2855	EMLOOP1
Ridge-horn Antenna (300-5000 MHz)	<input checked="" type="checkbox"/>	University of Michigan	UMRH1
Amplifier (5-1000 MHz)	<input checked="" type="checkbox"/>	Avantek, A11-1, A25-1S	AVAMP1
Amplifier (5-4500 MHz)	<input checked="" type="checkbox"/>	Avantek	AVAMP2
Amplifier (4.5-13 GHz)	<input type="checkbox"/>	Avantek, AFT-12665	AVAMP3
Amplifier (6-16 GHz)	<input type="checkbox"/>	Trek	TRAMP1
Amplifier (16-26 GHz)	<input type="checkbox"/>	Avantek	AVAMP4
LISN Box	<input type="checkbox"/>	University of Michigan	UMLISN1
Signal Generator	<input type="checkbox"/>	Hewlett-Packard 8657B	HPSG1

3. Device Under Test

3.1 Description & Block Diagram

The DUT is a 433.9 MHz keyfob transmitter designed for automotive/vehicular applications. It is powered by a 3VDC lithium battery and is housed in a plastic case approximately 7 x 4 x 1 cm in dimension. The DUT is manufactured by Lear Automotive Electronics and Electrical Products (Shanghai) Co., Ltd, Building 5, No. 509, Ren-Qing Road, Zhang Jiang Hi-Tech Park, Pu-Dong, Shanghai, China 201201.

Device	[Make], Model	[PN],SN	EMC Consideration
DUT	[Lear],	[C131191101000]	Normal Mode
DUT	[Lear],	[C131191101000]	CW Programmed

3.2 Variants and Samples

There is only a single variant of this product, as tested. Two samples were provided for testing, one normal operating sample and one sample programmed for CW transmission at the center operating frequency. On this device the end-user is able to remove the metal key on one end of the product to unlock the vehicle in the case of a battery failure. To ensure RF emissions compliance in all configurations, this device is tested for worst case emissions with (1) key inside the housing and (2) key removed. Minimal change in emissions is reported.

3.3 Modes of Operation

The DUT is capable of two modes of activation.

The primary mode of activation is via button press, which results in the lowest duty factor (worst case) transmission. This transmission consists of interwoven ASK and FSK words that continually step through three frequencies centered at 433.52 MHz, 433.92 MHz, and 434.32 MHz. Since all three frequencies are used sequentially, bandwidth is demonstrated to comply in a cumulative fashion.

The secondary mode of activation is by encoded, manually initiated, LF interrogation. This mode responds employing only a single high duty (low average) ASK response consisting of only a single transmitted word.

Both modes are documented herein, and the peak power setting for the DUT does not change for the different modes of operation.

3.4 Exemptions

None.

3.5 EMC Relevant Modifications

No EMI Relevant Modifications were performed by this test laboratory.

4. Emissions Limits

4.1 Radiated Emissions Limits

The DUT tested falls under the category of an Intentional Radiator. The applicable testing frequencies and corresponding emission limits set by both the FCC and IC are given in Tables 4.1 and 4.2 below.

Table 4.1. TX Emission Limits (FCC: 15.231(b), .205(a); IC: RSS-210 2.7 T4).

Frequency (MHz)	Fundamental Ave. E _{lim} (3m)		Spurious** Ave. E _{lim} (3m)	
	(μV/m)	dB (μV/m)	(μV/m)	dB (μV/m)
260.0-470.0	3750-12500*		375-1250	
433.9	6042	75.6	604.2	55.6
433.9	10966	80.8	1096.6	60.8
322-335.4 399.9-410 608-614	Restricted Bands		200	46.0
960-1240/1427(IC) 1300-1427 1435-1626.5 1645.5-1646.5 (IC) 1660-1710 1718.9-1722.2 2200-2300	Restricted Bands		500	54.0

* Linear interpolation, formula: $E = -7083 + 41.67 * f$ (MHz)

** Measure up to tenth harmonic; 120 kHz BW up to 1 GHz, 1 MHz BW above 1 GHz

Table 4.2. Spurious Emission Limits (FCC: 15.33, .35, .109/209; IC: RSS-210 2.7, T2)

Freq. (MHz)	E _{lim} (3m) μV/m	E _{lim} dB(μV/m)
30-88	100	40.0
88-216	150	43.5
216-960	200	46.0
960-2000	500	54.0

Note: Average readings apply above 1000 MHz (1 MHz BW), Quasi-Peak readings apply to 1000 MHz (120 kHz RBW), PRF of intentional emissions > 20 Hz for QPK to apply.

Power Line Conducted Emissions Limits

Table 4.3 Emission Limits (FCC:15.107 (CISPR); IC: RSS-Gen, 7.2.2 T2).

Frequency (MHz)	Class A (dBμV)		Class B (dBμV)	
	Quasi-peak	Average	Quasi-peak	Average
.150 - 0.50	79	66	66 - 56*	56 - 46*
0.50 - 5	73	60	56	46
5 - 30	73	60	60	50

Notes:

- The lower limit shall apply at the transition frequency
- The limit decreases linearly with the logarithm of the frequency in the range 0.15-0.50 MHz:

*Class B Quasi-peak: $\text{dB}\mu\text{V} = 50.25 - 19.12 * \log(f)$

*Class B Average: $\text{dB}\mu\text{V} = 40.25 - 19.12 * \log(f)$

- 9 kHz RBW

5. Measurement Procedures

5.1 Semi-Anechoic Chamber Radiated Emissions

To become familiar with the radiated emission behavior of the DUT, the device is first studied and measured in our shielded semi-anechoic chamber. In the chamber there is a set-up similar to that of an outdoor 3-meter site, with a turntable, an antenna mast, and a ground plane. Instrumentation includes spectrum analyzers and other equipment as needed.

The DUT is laid on the test table as shown in the included block diagram and/or photographs. A shielded loop antenna is employed when studying emissions from 9 kHz to 30 MHz. Above 30 MHz and below 250 MHz a biconical antenna is employed. Above 250 MHz a ridge or standard gain horn antennas are used. The spectrum analyzer resolution and video bandwidths are set so as to measure the DUT emission without decreasing the emission bandwidth (EBW) of the device. Emissions are studied for all orientations (3-axes) of the DUT and all test antenna polarizations. In the chamber, spectrum and modulation characteristics of intentional carriers are recorded. Receiver spurious emissions are measured with an appropriate carrier signal applied. Associated test data is presented in subsequent sections.

5.2 Outdoor Radiated Emissions

After measurements are performed indoors, emissions on our outdoor 3-meter Open Area Test Site (OATS) are made, when applicable. If the DUT connects to auxiliary equipment and is table or floor standing, the configurations prescribed in ANSI C63.4 are employed. Alternatively, an on-table layout more representative of actual use may be employed if the resulting emissions appear to be worst-case in such a configuration. Any intentionally radiating elements are placed on the test table flat, on their side, and on their end (3-axes) and worst case emissions are recorded. For each configuration the DUT is rotated 360 degrees about its azimuth and the receive antenna is raised and lowered between 1 and 4 meters to maximize radiated emissions from the device. Receiver spurious emissions are measured with an appropriate carrier signal applied. For devices with intentional emissions below 30 MHz, our shielded loop antenna at a 1 meter receive height is used. Low frequency field extrapolation to the regulatory limit distance is employed as needed. Emissions between 30 MHz and 1 GHz are measured using tuned dipoles and/or biconical antennas. Care is taken to ensure that the RBW and VBW used meet the regulatory requirements, and that the EBW of the DUT is not reduced. The Photographs included in this report show the Test Setup.

5.3 Radiated Field Computations

To convert the dBm values measured on the spectrum analyzer to dB(μ V/m), we use expression

$$E3(\text{dB}\mu\text{V/m}) = 107 + \text{PR} + \text{KA} - \text{KG} + \text{KE} - \text{CF}$$

where PR = power recorded on spectrum analyzer, dBm, measured at 3 m
 KA = antenna factor, dB/m
 KG = pre-amplifier gain, including cable loss, dB
 KE = duty correction factor, dB
 CF = distance conversion (employed only if limits are specified at alternate distance), dB

When presenting the data at each frequency, the highest measured emission under all of the possible DUT orientations (3-axes) is given.

5.4 Indoor Power Line Conducted Emissions

When applicable, power line conducted emissions are measured in our semi-anechoic chamber. If the DUT connects to auxiliary equipment and is table or floor standing, the configurations prescribed in ANSI C63.4 are employed. Alternatively, an on-table layout more representative of actual use may be employed if the resulting emissions appear to be worst-case in such a configuration.

The conducted emissions measured with the spectrum analyzer and recorded (in dBμV) from 0-2 MHz and 2-30 MHz for both the ungrounded (Hi) and grounded (Lo) conductors. The spectrum analyzer is set to peak-hold mode in order to record the highest peak throughout the course of functional operation. Only when the emission exceeds or is near the limit are quasi-peak and average detection used.

5.5 Supply Voltage Variation

Measurements of the variation in the fundamental radiated emission were performed with the supply voltage varied by no less than 85% and 115% of the nominal rated value. For battery operated equipment, tests were performed using a new battery, and worst case emissions are re-checked employing a new battery.

6. Test Results

6.1 Radiated Emissions

6.1.1 Correction for Pulse Operation

When the transmitter is activated by button press it transmits, in the worst-case, one 50.813 ms frame of Manchester encoded ASK data and one 20.125 ms frame of FSK data in any given 200 ms window. The worst case 100 ms window occurs when all of FSK and 29.5 ms of ASK frame are captured.

Alternatively, when interrogated by a manually activated LF signal, the DUT transmits no more than two 5.75 ms FSK frames in any given 100 ms window. See Figure 6.1. Computing the duty factor results in:

$$K_E(\text{Button ASK}) = (67.5 \text{ us} / 128.8 \text{ us}) \times (50.813 \text{ ms} / 100 \text{ ms}) = 0.266 \text{ or } -11.5 \text{ dB.}$$

$$K_E(\text{Button FSK}) = 20.125 \text{ ms} / 100 \text{ ms} = 0.201 \text{ or } -13.9 \text{ dB.}$$

$$K_E(\text{Button FSK+ partial ASK}) = ((67.5 \text{ us} / 128.8 \text{ us}) \times 29.5 \text{ ms} + 20.125 \text{ ms}) / 100 \text{ ms} = 0.356 \text{ or } \mathbf{-9.0 \text{ dB.}}$$

$$K_E(\text{LF FSK}) = 2 \times (5.75 \text{ ms} / 100 \text{ ms}) = 0.012 \text{ or } -18.8 \text{ dB.}$$

Thus, the worst case duty cycle of **-9.0 dB** is thus applied to all CW measurements made.

6.1.2 Emission Spectrum

The relative DUT emission spectrum is recorded and is shown in Figure 6.2.

6.1.3 Emission Bandwidth

The emission bandwidth of the signal is shown in Figure 6.3. The allowed 99% bandwidth is 0.25% of 433.52 MHz, or 1.0838 MHz. From the plot we see that the EBW is 942.0 kHz, and the center frequency is 433.92 MHz.

6.1.4 Supply Voltage and Supply Voltage Variation

The DUT has been designed to be powered by a 3 VDC battery. For this test, relative radiated power was measured at the fundamental as the voltage was varied from 2.0 to 4.0 volts. The emission variation is shown in Figure 6.4.

Batteries:	before testing	$V_{oc} =$	3.24 V
	after testing	$V_{oc} =$	2.97 V
Ave. current from batteries		$I =$	9.2 mA (cw)

6.2 Conducted Emissions

These tests do not apply, since the DUT is powered from a 3 VDC battery.

Table 6.1 Highest Emissions Measured

Radiated Emission - RF											Lear Fisker RKE; FCC/IC
#	Freq. MHz	Ant. Used	Ant. Pol.	Pr dBm	Det. Used	Ka dB/m	Kg dB	E3* dBμV/m	E3lim dBμV/m	Pass dB	Comments
1	With Key in housing										
2	433.9	Dip	H	-25.4	Pk	21.5	21.3	72.8	80.8	8.0	flat
3	433.9	Dip	V	-24.7	Pk	21.5	21.3	73.5	80.8	7.3	end
4	867.8	Dip	H	-69.4	Pk	27.8	17.9	38.5	60.8	22.3	flat
5	867.8	Dip	V	-75.2	Pk	27.8	17.9	32.7	60.8	28.1	end
6	1301.7	Horn	H	-45.6	Pk	20.7	28.1	45.0	54.0	9.0	flat
7	1735.6	Horn	H	-39.7	Pk	21.9	28.1	52.1	60.8	8.7	flat
8	2169.5	Horn	H	-54.0	Pk	22.9	26.5	40.4	60.8	20.4	flat
9	2603.4	Horn	H	-47.4	Pk	24.1	25.7	49.0	60.8	11.8	flat
10	3037.3	Horn	H	-55.9	Pk	25.5	23.9	43.6	60.8	17.2	end
11	3471.2	Horn	H	-57.1	Pk	26.8	23.2	44.5	60.8	16.3	end
12	3905.1	Horn	H	-60.0	Pk	28.1	22.4	43.8	54.0	10.2	end
13	4339.0	Horn	H	-70.8	Pk	29.5	16.2	40.4	54.0	13.6	end
14	With Key removed from housing										
15	433.9	Dip	H	-25.6	Pk	21.5	21.3	72.6	80.8	8.2	flat
16	433.9	Dip	V	-25.3	Pk	21.5	21.3	72.9	80.8	7.9	side
17	867.8	Dip	H	-70.5	Pk	27.8	17.9	37.4	60.8	23.4	flat
18	867.8	Dip	V	-76.9	Pk	27.8	17.9	31.0	60.8	29.8	side
19	1301.7	Horn	H	-44.3	Pk	20.7	28.1	46.3	54.0	7.7	side
20	1735.6	Horn	H	-50.0	Pk	21.9	28.1	41.8	60.8	19.0	end
21	2169.5	Horn	H	-53.0	Pk	22.9	26.5	41.4	60.8	19.4	flat
22	2603.4	Horn	H	-46.6	Pk	24.1	25.7	49.8	60.8	11.0	flat
23	3037.3	Horn	H	-57.7	Pk	25.5	23.9	41.8	60.8	19.0	flat
24	3471.2	Horn	H	-55.6	Pk	26.8	23.2	46.0	60.8	14.8	flat
25	3905.1	Horn	H	-60.3	Pk	28.1	22.4	43.5	54.0	10.5	side
26	4339.0	Horn	H	-70.3	Pk	29.5	16.2	40.9	54.0	13.1	end
27											
Digital Radiated Emissions											
#	Freq. kHz	Ant. Used	Ant. Pol.	Pr dBm	Det. Used	Ka dB/m	Kg dB	E3 dBμV/m	E3lim dBμV/m	Pass dB	Comments
1											
2											
3											
4	Digital emissions more than 20 dB below FCC/IC Class B Limit.										
5											
6											
7											
8											
9											

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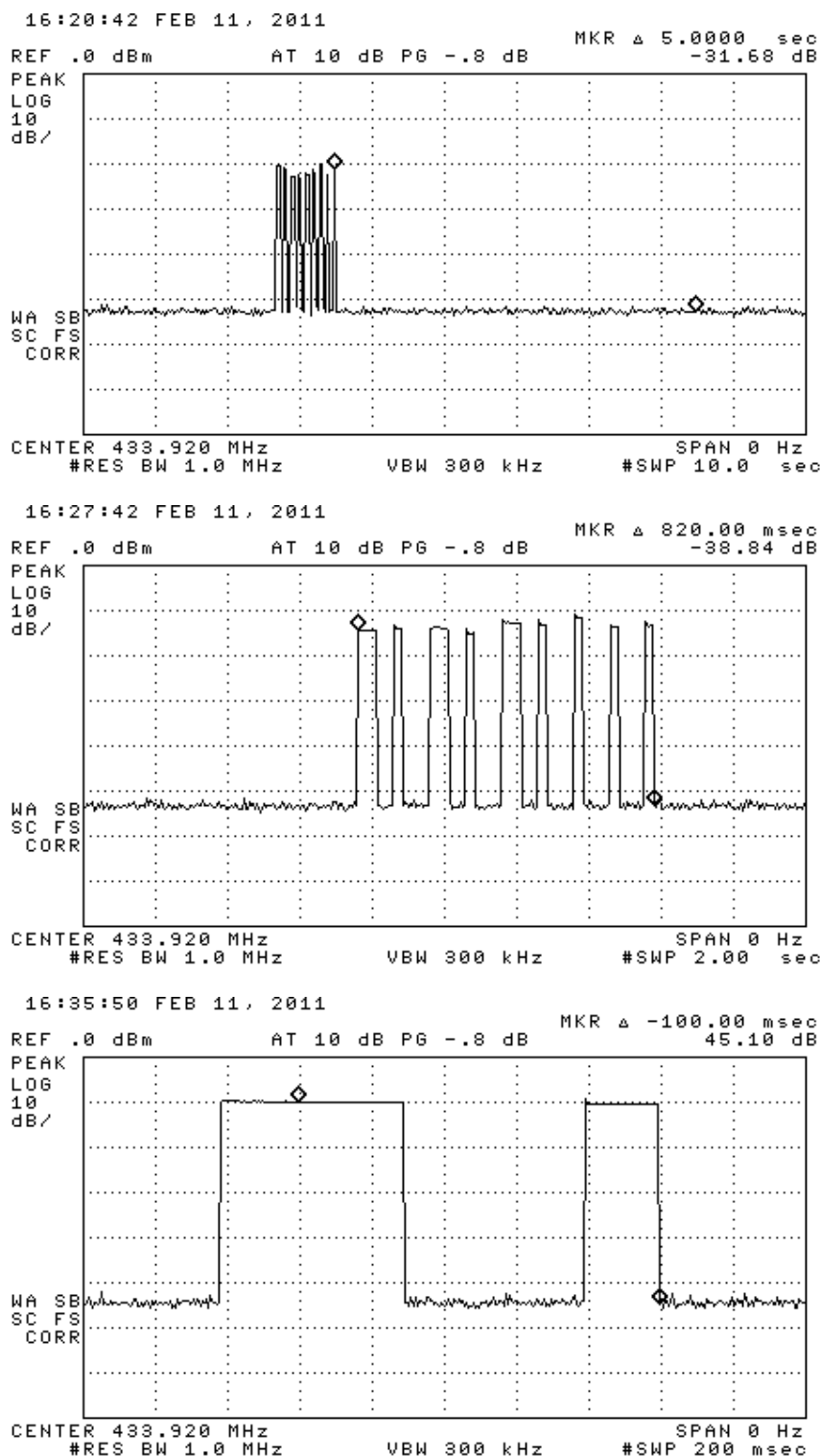


Figure 6.1(a). Manual Button Press Transmission characteristics. (top) 5 second turn-off after release, (center) Transmission from single button press (a minimum length press would show only 3 repeated pairs of frames (ASK frame then FSK frame, ASK then FSK, ASK then FSK) , (bottom) worst-case 100 ms window.

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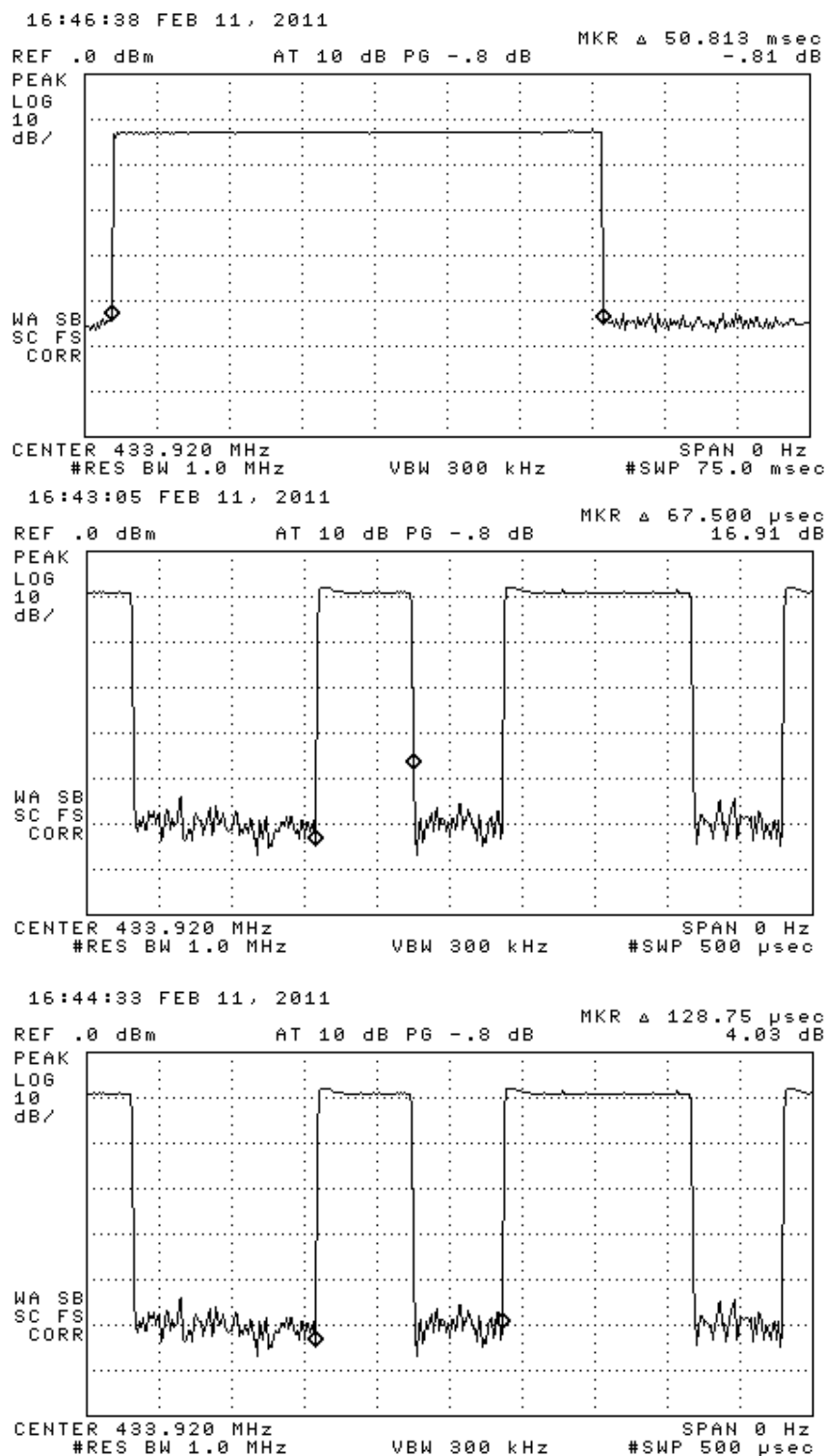


Figure 6.1(b). Manchester encoded ASK Frame characteristics. (top) frame length, (center) Manchester packet length , (bottom) Manchester packet period.

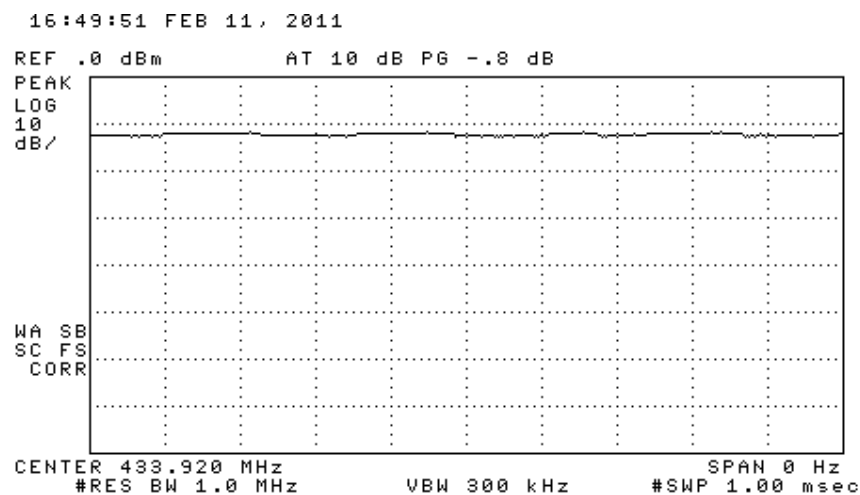
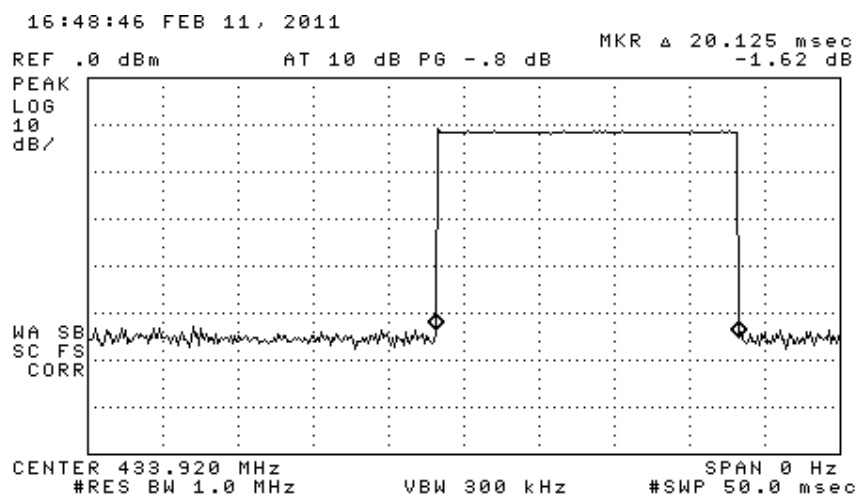


Figure 6.1(c). FSK Frame characteristics. (top) frame length, (bottom) frame duty.

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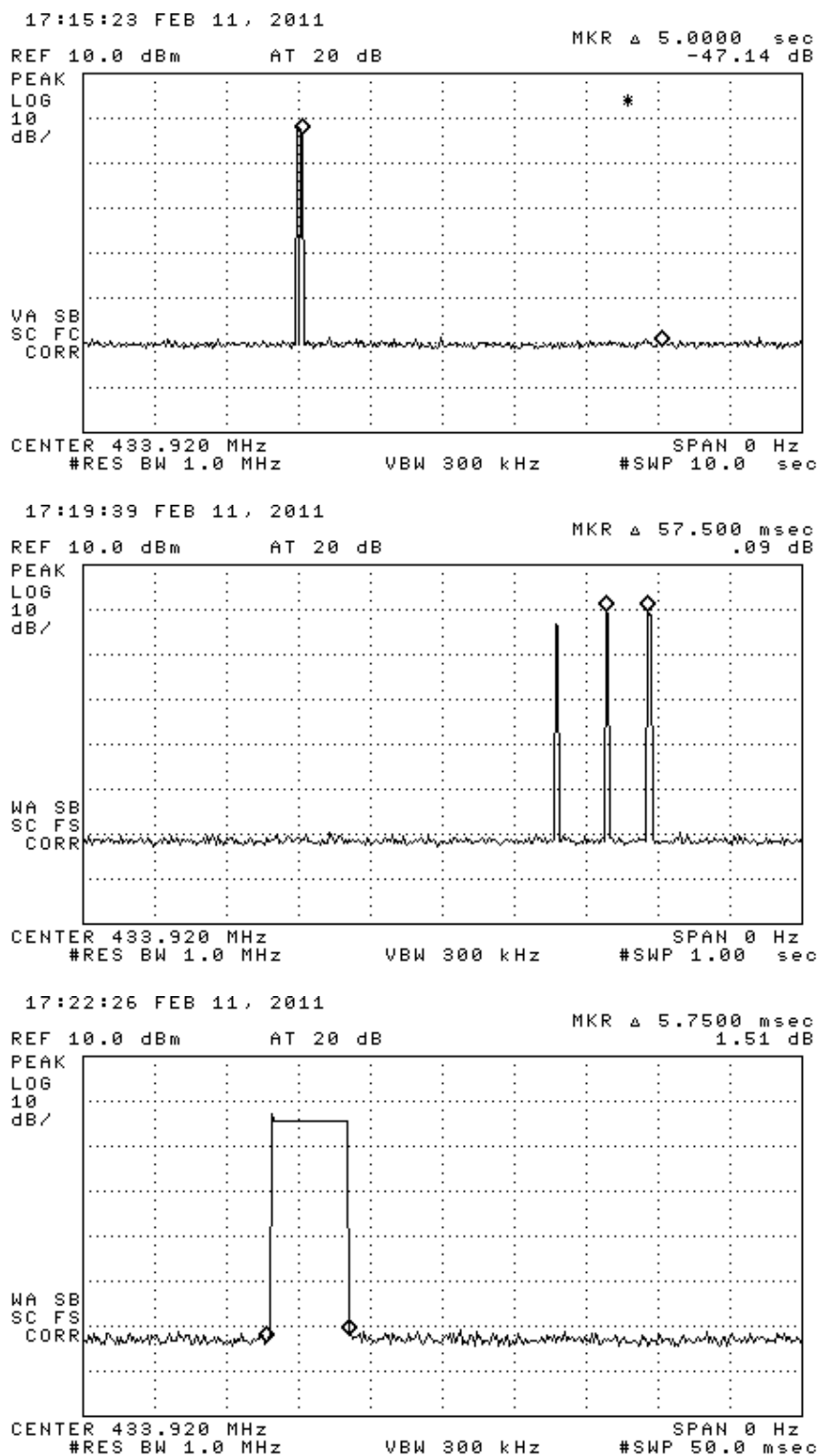


Figure 6.1(d). Manual LF Activated FSK Transmission. (top) 5 second turn-off after door-handle release, (center) LF activated Transmission (max of two frames per 100 ms window), (bottom) FSK frame length.

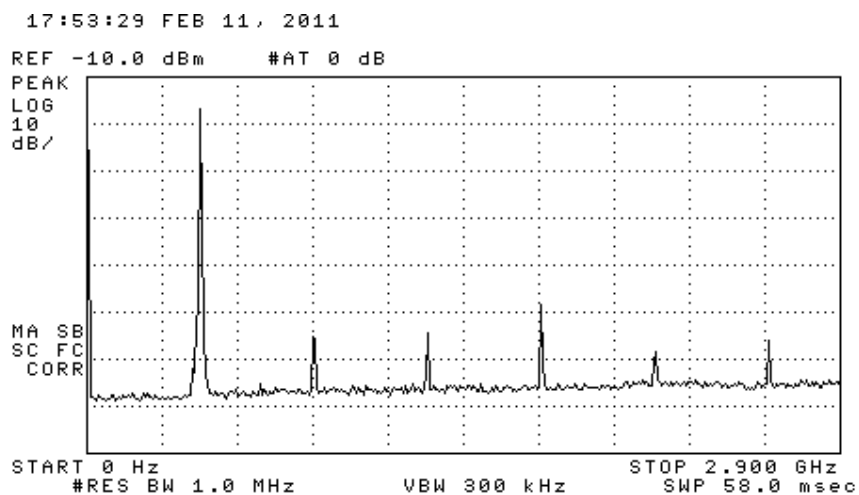


Figure 6.2. Emission spectrum of the DUT (pulsed emission). Amplitudes are only indicative (not calibrated).

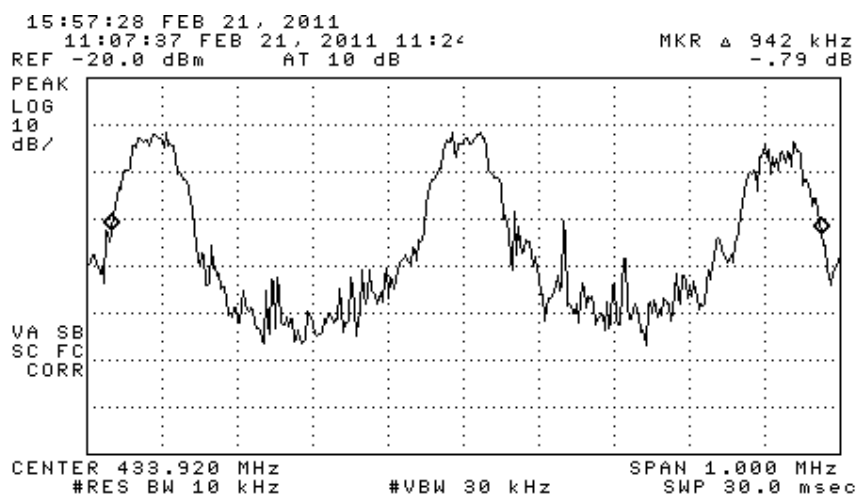


Figure 6.3. Measured emission bandwidth of the DUT (pulsed).

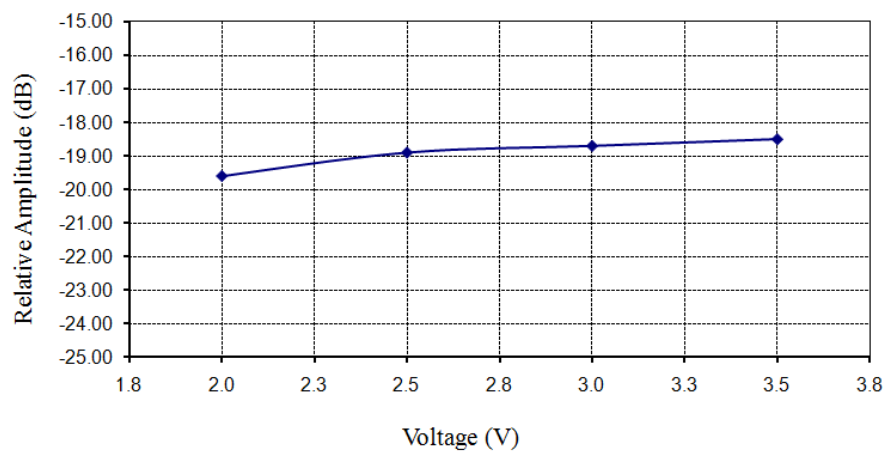


Figure 6.4. Relative emission at fundamental vs. supply voltage (pulsed).



Photograph 6.5. DUT on OATS (one of three axes tested)



Photograph 6.6. Close-up of DUT on OATS (one of three axes tested)